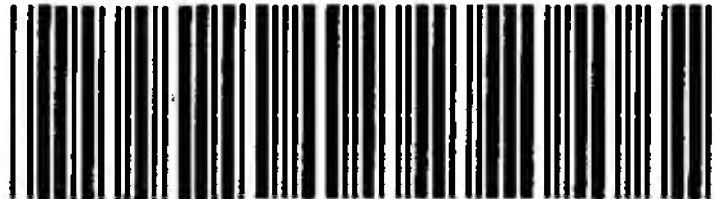


## **Search Notes**



**Application/Control No.**

10/561.133

Examiner

Deborah Yee

**Applicant(s)/Patent under  
Reexamination**

SUGIURA ET AL.

## **Art Unit**

1793

**SEARCHED**

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
148	602,654	1/16/2008	/DY/
148	320		
148	330-336		